

In Place of FORM PTO-1449 (Modified)

**LIST OF PATENTS AND PUBLICATIONS FOR
APPLICANT'S INFORMATION DISCLOSURE
STATEMENT**Serial No. 10/047,784Applicant: Barker, et. al.Filing Date: 1/14/2002Group: 2122Atty. Docket No. RSW920010051US1**U. S. PATENT DOCUMENTS**

Examiner Initial	Document Number	Date	Name	Class	Subclass	Filing Date if Appropriate
JDR	AA 2003/0095142	05/2003	Patrizio et al.	345	744	
JDR	AB 2002/0107872	08/2002	Hudis et al.	707	104.1	
JDR	AC 2003/0135648	07/2003	Porter	709	246	
JDR	AD 2003/0110073	06/2003	Briel et al.	705	10	
JDR	AE 2002/0069275	06/2002	Tindal	709	223	
JPR	AF 2003/0018964	01/2003	Fox et al.	717	177	
JDR	AG 2003/0095145	05/2003	Patrizio et al.	345	764	
JDR	AH 2004/0015889	01/2004	Todd et al.	717	137	
JDR	AI 2002/0140743	10/2002	DeLuca et al.	345	835	
JDR	AJ 2003/0177477	09/2003	Fuchs	717	136	
JDR	AK 2002/0091809	07/2002	Menzies et al.	709	223	
JDR	AL 6,708,074	03/2004	Chi et al.	700	121	
JDR	AM 6,252,593	06/2001	Gti	345	781	

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Examiner Initial	Document Number	Date	Country	Class	Subclass	Translation Yes No
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_____	AP					

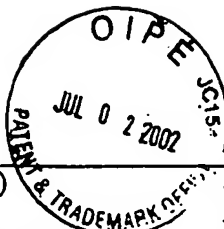
OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

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Examiner: _____

Date Considered: 1/4/05

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.



In Place of FORM PTO-1449 (Modified)

Serial No. 10/047,784

Applicant: Barker et al.

Filing Date: January 14, 2002

Group: 2122

Atty. Docket No. RSW920010051US1

**LIST OF PATENTS AND PUBLICATIONS FOR
APPLICANT'S INFORMATION DISCLOSURE
STATEMENT**

U. S. PATENT DOCUMENTS

Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date if Appropriate
JDR	AA	6,134,559	Oct. 17, 2000	Brumme et al.	707	103	
	AB	6,125,442	Sep. 26, 2000	Maves et al.	712	220	
	AC	6,118,446	Sep. 12, 2000	Jones et al.	345	333	
	AD	6,115,646	Sep. 5, 2000	Fizsman et al.	700	181	
	AE	5,970,490	Oct. 19, 1999	Morgenstern	707	10	
	AF	5,872,966	Feb. 16, 1999	Burg	395	651	
	AG	5,317,742	May 31, 1994	Bapat	395	700	
	AH	5,237,688	Aug. 17, 1993	Calvert et al.	395	700	
	AI	6,085,196	Jul. 4, 2000	Motoyama et al.	707	102	
	AJ	6,008,805	Dec. 28, 1999	Land et al.	345	335	
	AK	5,652,884	Jul. 29, 1997	Palevich	395	651	
	AL	6,157,953	Dec. 5, 2000	Chang et al.	709	225	
	AM	6,108,712	Aug. 22, 2000	Hayes, Jr.	709	246	
	AN	6,161,126	Dec. 12, 2000	Wies et al.	709	203	
	AO	6,144,962	Nov. 7, 2000	Weinberg et al.	707	10	
	AP	6,035,119	Mar. 7, 2000	Massena et al.	395	701	
	AQ	5,958,008	Sep. 28, 1999	Pogrebisky et al.	709	223	
	AR	5,870,559	Feb. 9, 1999	Leshem et al.	395	200.54	
JDR	AS	5,829,053	Oct. 27, 1998	Smith et al.	711	202	

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FOREIGN PATENT DOCUMENTS

Examiner Initial	Document Number	Date	Country	Class	Subclass	Translation Yes No
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